Search Notes

	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/565,434	FURUKAWA E1	ΓAL.
Ī	Examiner	Art Unit	
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INT	INTERFERENCE SEARCHED				
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
STN (CAPLUS BIOSIS SCISEARCH MEDLINE) WEST Inventor Search	6/28/2006	BDC